Silicon Carbide (SiC) MOSFET – EliteSiC, 40 mohm, 1200 V, M3S, D2PAK-7L

NTBG040N120M3S

Features

- Typ. $R_{DS(on)} = 40 \text{ m}\Omega @ V_{GS} = 18 \text{ V}$
- Ultra Low Gate Charge $(Q_{G(TOT)} = 75 \text{ nC})$
- High Speed Switching with Low Capacitance (Coss = 80 pF)
- 100% Avalanche Tested
- This Device is Halide Free and RoHS Compliant with Exemption 7a, Pb-Free 2LI (on Second Level Interconnection)

Typical Applications

- Solar Inverters
- Electric Vehicle Charging Stations
- Uninterruptible Power Supplies (UPS)
- Energy Storage Systems
- Switch Mode Power Supplies (SMPS)

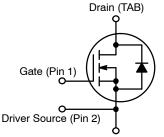
MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Value	Unit		
Drain-to-Source Voltage			V_{DSS}	1200	٧
Gate-to-Source Voltage			V _{GS}	-10/+22	٧
Continuous Drain Current (Notes 2, 3)	Steady State	T _C = 25°C	I _D	57	Α
Power Dissipation (Note 2)			P_{D}	263	W
Continuous Drain Current (Notes 2, 3)	Steady State	T _C = 100°C	I _D	40	Α
Power Dissipation (Note 2)			P _D	131	W
Pulsed Drain Current (Note 4) T _C = 25°C			I _{DM}	149	Α
Operating Junction and Storag Range	T _J , T _{stg}	-55 to +175	°C		
Source Current (Body Diode) $T_C = 25^{\circ}C$, $V_{GS} = -3 \text{ V}$ (Note 2)	I _S	50	Α		
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 16.9 A, L = 1 mH) (Note 5)			E _{AS}	143	mJ
Maximum Temperature for Soldering (10 s)			T_L	270	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface mounted on a FR-4 board using1 in2 pad of 2 oz copper.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 3. The maximum current rating is based on typical RDS(on) performance.
- 4. Repetitive rating, limited by max junction temperature.
- 5. E_{AS} of 143 mJ is based on starting T_J = 25°C; L = 1 mH, I_{AS} = 16.9 A, V_{DD} = 100 V, V_{GS} = 18 V.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
1200 V	54 mΩ @ 18 V	57 A



Power Source (Pins 3, 4, 5, 6, 7)

N-CHANNEL MOSFET



D2PAK-7L CASE 418BJ

MARKING DIAGRAM

BG040N 120M3S AYWWZZ

BG040N120M3S = Specific Device Code

A = Assembly Location

Y = Year WW = Work Week ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping
NTBG040N120M3S	D2PAK-7L	800 / Tape & Reel

THERMAL CHARACTERISTICS

Parameter	Symbol	Max	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ heta JC}$	0.57	°C/W
Junction-to-Ambient - Steady State (Notes 1, 2)		40	

RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Value	Unit
Operation Values of Gate-to-Source Voltage	V_{GSop}	−5−3 +18	V

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF-STATE CHARACTERISTICS	•		•	•	•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	1200	_	_	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 1 mA, referenced to 25°C (Note 7)	-	0.3	-	V/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 1200 V	-	-	100	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{GS} = +22/-10 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	±1	μΑ
ON-STATE CHARACTERISTICS						
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 10 \text{ mA}$	2.04	2.9	4.4	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 18 V, I _D = 20 A, T _J = 25°C	-	40	54	mΩ
		V _{GS} = 18 V, I _D = 20 A, T _J = 175°C (Note 7)	-	80	-	
Forward Transconductance	9 _F s	V _{DS} = 10 V, I _D = 20 A (Note 7)	-	16	-	S
CHARGES, CAPACITANCES & GATE RI	ESISTANCE					
Input Capacitance	C _{ISS}	V_{GS} = 0 V, f = 1 MHz, V_{DS} = 800 V	_	1700	_	pF
Output Capacitance	C _{OSS}		_	80	-]
Reverse Transfer Capacitance	C _{RSS}		_	7	-	1
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -3/18 \text{ V}, V_{DS} = 800 \text{ V},$ $I_{D} = 20 \text{ A}$	-	75	-	nC
Threshold Gate Charge	Q _{G(TH)}	I _D = 20 A	_	4.4	-	
Gate-to-Source Charge	Q _{GS}		_	14	-	1
Gate-to-Drain Charge	Q_{GD}		_	22	-	
Gate-Resistance	R _G	f = 1 MHz	-	3.8	-	Ω
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = -3/18 \text{ V},$	-	13	-	ns
Rise Time	t _r	$V_{DS} = 800 \text{ V},$ $I_{D} = 20 \text{ A},$	_	16	-	
Turn-Off Delay Time	t _{d(OFF)}	$R_G = 4.7 \Omega$ Inductive Load (Notes 6, 7)	_	38	_	1
Fall Time	t _f	_ (, .)	_	10	_	
Turn-On Switching Loss	E _{ON}		_	193	_	μJ
Turn-Off Switching Loss	E _{OFF}		-	66	_	
Total Switching Loss	E _{tot}		_	259	_]

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified) (continued)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
SOURCE-DRAIN DIODE CHARACTERIST	ics	•				
Continuous Source-Drain Diode Forward Current (Note 2)	I _{SD}	V _{GS} = -3 V, T _C = 25°C (Note 7)	-	-	50	Α
Pulsed Source-Drain Diode Forward Current (Note 4)	I _{SDM}]	=	-	149	
Forward Diode Voltage	V_{SD}	$V_{GS} = -3 \text{ V}, I_{SD} = 20 \text{ A}, T_J = 25^{\circ}\text{C}$	-	4.5	-	V
Reverse Recovery Time	t _{RR}	$V_{GS} = -3/18 \text{ V}, I_{SD} = 20 \text{ A},$	-	16.8	-	ns
Reverse Recovery Charge	Q_{RR}	dl _S /dt = 1000 A/μs, V _{DS} = 800 V (Note 7)	-	82	-	nC
Reverse Recovery Energy	E _{REC}	1	-	7.9	-	μJ
Peak Reverse Recovery Current	I _{RRM}	1	-	9.8	-	Α
Charge time	t _A	1	-	9.6	-	ns
Discharge time	t _B	1	_	7.2	-	ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. E_{ON}/E_{OFF} result is with body diode

7. Defined by design, not subject to production test.

TYPICAL CHARACTERISTICS

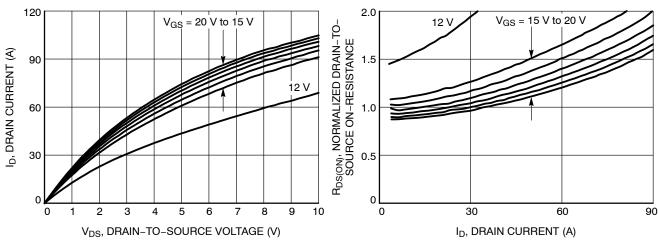


Figure 1. On-Region Characteristics

Figure 2. Normalized On–Resistance vs. Drain Current and Gate Voltage

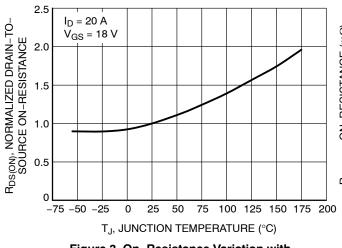


Figure 3. On–Resistance Variation with Temperature

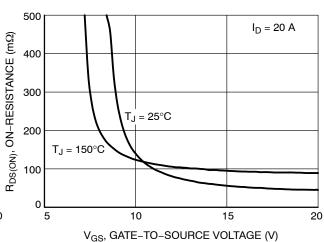


Figure 4. On-Resistance vs. Gate-to-Source Voltage

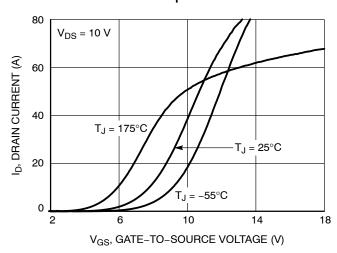


Figure 5. Transfer Characteristics

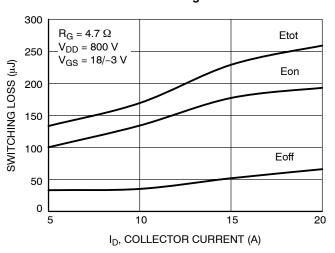


Figure 6. Switching Loss vs. Collector Current

TYPICAL CHARACTERISTICS

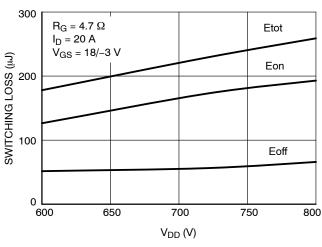


Figure 7. Switching Loss vs. Gate Resistance

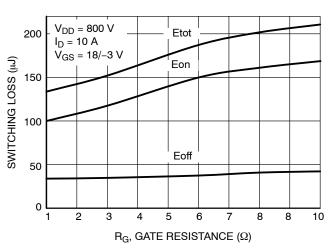


Figure 8. Switching Loss vs. Gate Resistance

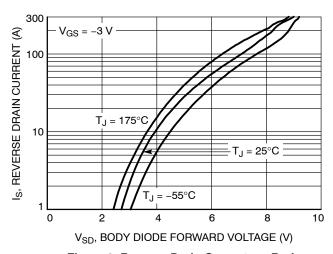


Figure 9. Reverse Drain Current vs. Body Diode Forward Voltage

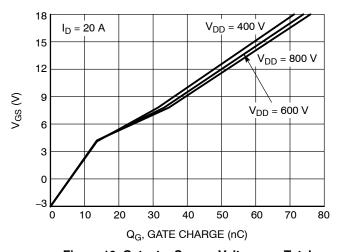


Figure 10. Gate-to-Source Voltage vs. Total Charge

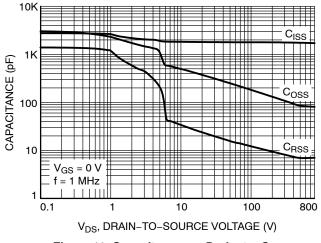


Figure 11. Capacitance vs. Drain-to-Source Voltage

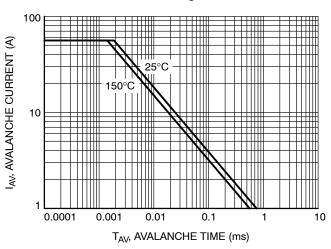


Figure 12. Unclamped Inductive Switching Capability

TYPICAL CHARACTERISTICS

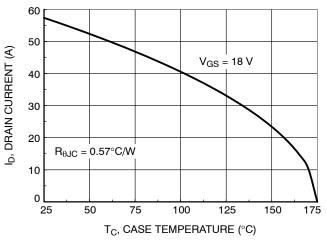


Figure 13. Maximum Continuous Drain Current vs. Case Temperature

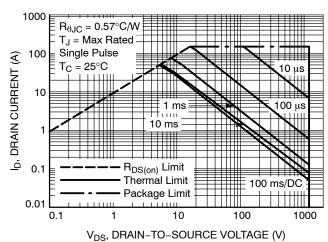


Figure 14. Safe Operating Area

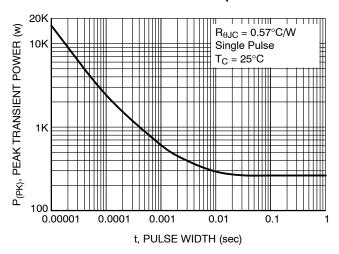


Figure 15. Single Pulse Maximum Power Dissipation

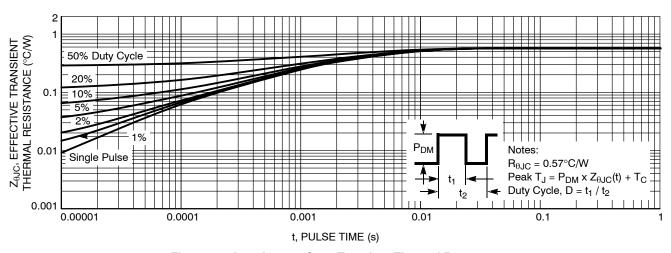
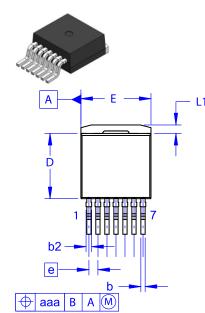


Figure 16. Junction-to-Case Transient Thermal Response



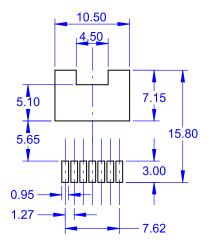


E1

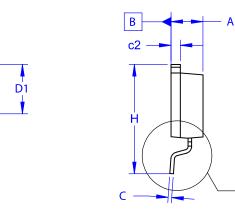
8

3.20 MIN

D²PAK7 (TO-263-7L HV) CASE 418BJ ISSUE B



LAND PATTERN RECOMMENDATION



DATE 16 AUG 2019

NOTES:

A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.

OUT OF JEDEC STANDARD VALUE.
D. DIMENSION AND TOLERANCE AS PER ASME
Y14.5-2009.

E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

54	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	4.30	4.50	4.70		
A1	0.00	0.10	0.20		
b2	0.60	0.70	0.80		
b	0.51	0.60	0.70		
С	0.40	0.50	0.60		
c2	1.20	1.30	1.40		
D	9.00	9.20	9.40		
D1	6.15	6.80	7.15		
Е	9.70	9.90	10.20		
E1	7.15	7.65	8.15		
е	~	1.27	~		
Н	15.10	15.40	15.70		
L	2.44	2.64	2.84		
L1	1.00	1.20	1.40		
L3	~	0.25	~		
aaa	~	~	0.25		

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code

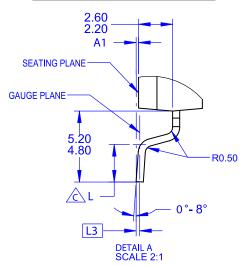
A = Assembly Location

Y = Year

WW = Work Week

G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.



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DESCRIPTION:	D ² PAK7 (TO-263-7L HV)		PAGE 1 OF 1	

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